

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10596625	SYFRIG, BENNO
	<b>Examiner</b>	<b>Art Unit</b>
	Bashaw, Heidi M	3709

### **SEARCHED**

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
433	152, 161, 165-166, 215	8.21.2007	HMB
606	80	8.21.2007	HMB
	Updated	3.28.2008	HMB

### **SEARCH NOTES**

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
W/ Wilson on above search	8.20.2007	HMB

### **INTERFERENCE SEARCH**

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>